

## **Supplementary Information**

# **Trap distribution tailoring guided design of a super-long persistent phosphor Ba<sub>2</sub>SiO<sub>4</sub>:Eu<sup>2+</sup>, Ho<sup>3+</sup> and photostimulable luminescence for optical information storage**

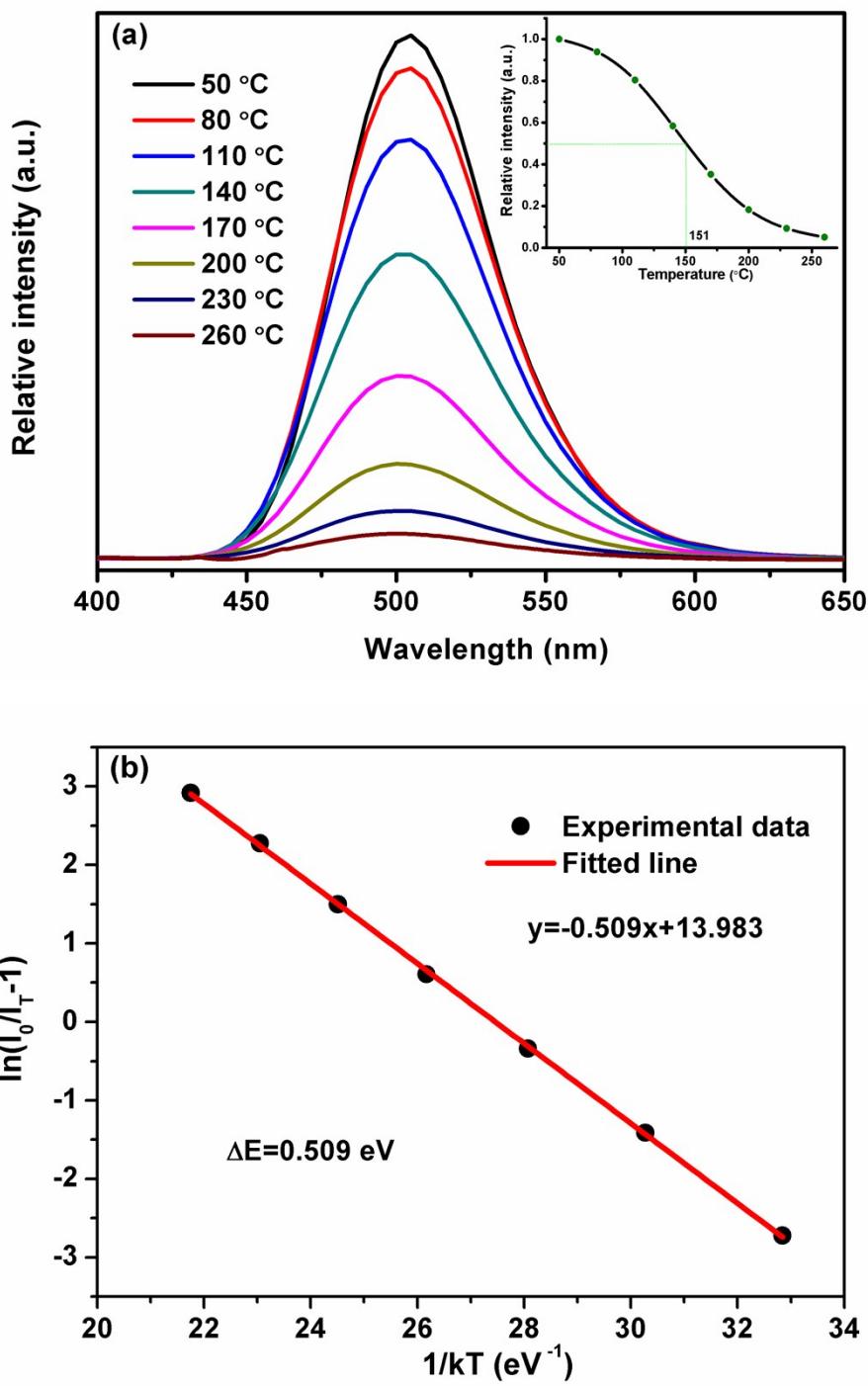
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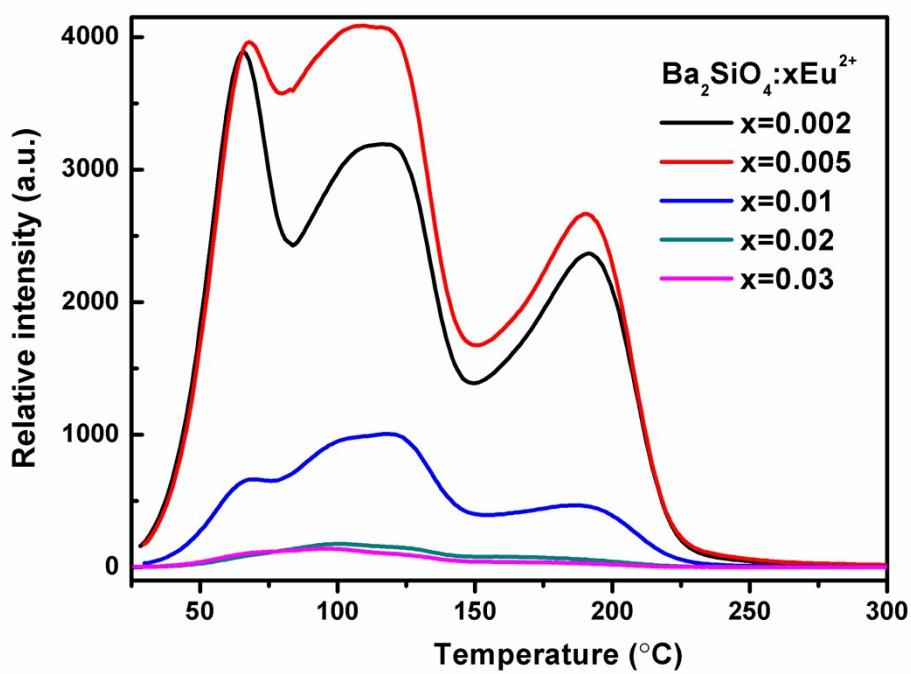
**Table S1.** Refined structure parameters of  $\text{Ba}_2\text{SiO}_4:0.005\text{Eu}^{2+}$  derived from the Rietveld refinement of X-ray diffraction data.

Atom	Wyckoff position	x	y	z	Frac
<b>Ba1</b>	4c	0.2500	0.0864	0.1610	1.0000
<b>Ba2</b>	4c	0.2500	0.6945	0.0081	1.0000
<b>Si</b>	4c	0.2500	0.4200	0.2282	1.0000
<b>O1</b>	4c	0.2500	0.5705	0.3097	1.0000
<b>O2</b>	8d	0.0195	0.3479	0.3051	1.0000
<b>O3</b>	4c	0.2500	0.4159	0.0130	1.0000

Cell parameters:  $a = 5.805 \text{ \AA}$ ,  $b = 10.204 \text{ \AA}$ ,  $c = 7.497 \text{ \AA}$ ,  $V = 444.064 \text{ \AA}^3$ ,  $Z = 4$ ; space group: pmcn (no.62); Reliability factors:  $R_{wp} = 9.89\%$ ,  $R_p = 9.51\%$  and  $\chi^2 = 1.407$



**Fig. S1** (a) Emission spectra of  $\text{Ba}_2\text{SiO}_4:0.005\text{Eu}^{2+}, 0.01\text{Ho}^{3+}$  at temperature between 50 and 260 °C. Inset: the temperature dependence of the relative emission intensity of  $\text{Ba}_2\text{SiO}_4:0.005\text{Eu}^{2+}, 0.01\text{Ho}^{3+}$ ; (b) relationship of  $\ln(I_0/I_{T-1})$  versus  $1/kT$  for  $\text{Ba}_2\text{SiO}_4:0.005\text{Eu}^{2+}, 0.01\text{Ho}^{3+}$  based on Eq. (2).



**Fig. S2** TL spectra of  $\text{Ba}_2\text{SiO}_4:\text{xEu}^{2+}$  ( $\text{x} = 0.002\text{-}0.03$ ) phosphors.